



# SPECIFICATION

SPEC. No. \_\_\_\_\_

DATE : \_\_\_\_\_

Customer  
  
\_\_\_\_\_

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS  
C2012, C3216, C3225, C4532, C5750 Type  
16V to 630V / X7R, X8R Characteristics (OPEN MODE)

Please sign and return this specification to your local TDK representatives. If orders are placed without returned documentation, we must consider you found the specification acceptable.

## THIS SPECIFICATION IS RECEIVED

DATE: \_\_\_\_\_ YEAR \_\_\_\_\_ MONTH \_\_\_\_\_ DAY \_\_\_\_\_

TDK-EPC Corporation  
1-13-1, Nihonbashi, Chuo-ku, Tokyo  
103-0027, Japan

### ENGINEERING

ISSUED	CHECKED	APPROVED
DATE	DATE	DATE

Sales Office \_\_\_\_\_

Sales Tel. \_\_\_\_\_ ( ) \_\_\_\_\_

PRODUCT CLASSIFICATION  
CODE

040320

## 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over other relevant specifications. Production places defined in this specification shall be TDK-EPC Corporation Japan, TDK (Suzhou) Co., Ltd, TDK-EPC HONG KONG LIMITED, TDK (Malaysia) Sdn. Bhd, and TDK Components U.S.A. Inc.

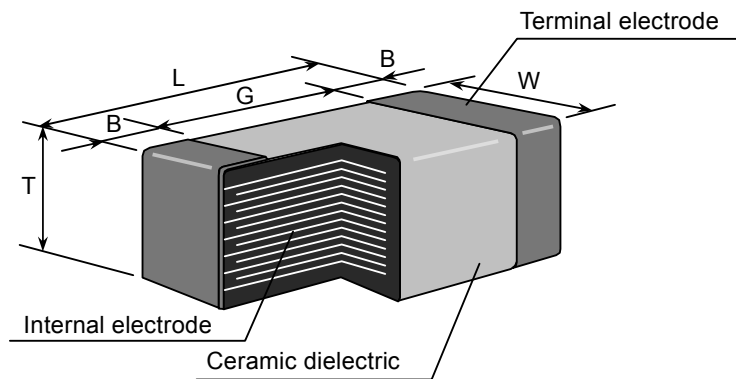
### EXPLANATORY NOTE:

This specification warrants the quality of the TDK ceramic chip capacitors. The product should be evaluated and confirmed in your product before use. If the use of the product exceeds the bounds of this specification, we can not guarantee its quality and/or reliability.

## 2. CODE CONSTRUCTION

(Example)     C2012     X7R     2A     223     K     T     5000  
                   (1)        (2)        (3)        (4)        (5)        (6)        (7)

### 1. Type



Please refer to product list for the dimension of each product. See Section 9 for inside structure and material.

### 2. Temperature Characteristics (Details are shown on Section 8, No.6)

### 3. Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V
1 E	DC 25 V
1 C	DC 16 V

### 4. Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and second digits identify the first and second significant figures of the capacitance; the third digit identifies the multiplier.

R is designated for a decimal point.

Example 223 → 22,000 pF

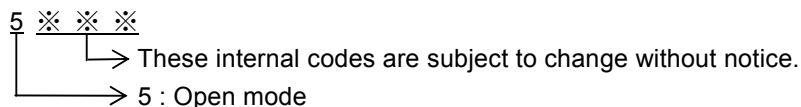
5. Capacitance tolerance

Symbol	Tolerance
K	± 10 %
M	± 20 %

6. Packaging

Symbol	Packaging
B	Bulk
T	Taping

7. TDK Internal Code



### 3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

1. Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitance tolerance		Rated capacitance
2	X7R X8R	10uF and under	K (± 10 %) M (± 20 %)	E – 6 series
		Over 10uF	M (± 20 %)	

2. Capacitance Step in E series

E series	Capacitance Step					
E- 6	1.0	1.5	2.2	3.3	4.7	6.8

### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X7R	-55°C	125°C	25°C
X8R	-55°C	150°C	25°C

### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH  
6 months Max.

### 6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate. Please inquire separate specification for the large case sizes when mounted on the substrate.

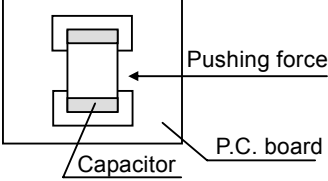
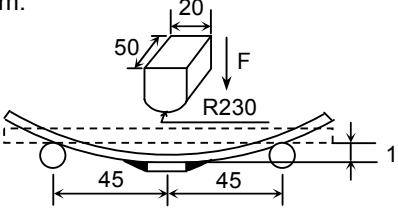
### 7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the local Industrial Waste Laws.

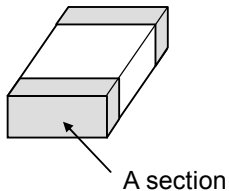
## 8. PERFORMANCE

No.	Item	Performance	Test or inspection method											
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3X)											
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. whichever smaller (As for the capacitors of rated voltage 16V DC, 10,000 MΩ or 100MΩ·μF min.)	Apply rated voltage for 60s. As for the rated voltage 630V DC, apply 500V DC.											
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	<table border="1"> <thead> <tr> <th>Rated voltage</th> <th>Apply voltage</th> </tr> </thead> <tbody> <tr> <td>100V and under</td> <td>2.5 × rated voltage</td> </tr> <tr> <td>250, 630V</td> <td>1.5 × rated voltage</td> </tr> </tbody> </table> <p>Above DC voltage shall be applied for 1 to 5s. Charge / discharge current shall not exceed 50mA.</p>	Rated voltage	Apply voltage	100V and under	2.5 × rated voltage	250, 630V	1.5 × rated voltage					
Rated voltage	Apply voltage													
100V and under	2.5 × rated voltage													
250, 630V	1.5 × rated voltage													
4	Capacitance	Within the specified tolerance.	<table border="1"> <thead> <tr> <th>Class</th> <th>Rated Capacitance</th> <th>Measuring frequency</th> <th>Measuring voltage</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Class 2</td> <td>10uF and under</td> <td>1kHz±10%</td> <td>1.0±0.2Vrms.</td> </tr> <tr> <td>Over 10uF</td> <td>120Hz±20%</td> <td>0.5±0.2Vrms.</td> </tr> </tbody> </table>	Class	Rated Capacitance	Measuring frequency	Measuring voltage	Class 2	10uF and under	1kHz±10%	1.0±0.2Vrms.	Over 10uF	120Hz±20%	0.5±0.2Vrms.
Class	Rated Capacitance	Measuring frequency	Measuring voltage											
Class 2	10uF and under	1kHz±10%	1.0±0.2Vrms.											
	Over 10uF	120Hz±20%	0.5±0.2Vrms.											
5	Dissipation Factor (Class 2)	<table border="1"> <thead> <tr> <th>T.C.</th> <th>Rated voltage</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td rowspan="2">X7R X8R</td> <td>1H,1E</td> <td>0.03 max.</td> </tr> <tr> <td>Below 16V DC</td> <td>0.05 max.</td> </tr> </tbody> </table>	T.C.	Rated voltage	D.F.	X7R X8R	1H,1E	0.03 max.	Below 16V DC	0.05 max.	See No.4 in this table for measuring condition.			
T.C.	Rated voltage	D.F.												
X7R X8R	1H,1E	0.03 max.												
	Below 16V DC	0.05 max.												

(8. Performance, continued)

No.	Item	Performance	Test or inspection method										
6	Temperature Characteristics of Capacitance (Class 2)	<p style="text-align: center;">Capacitance Change (%)</p> <hr/> <p style="text-align: center;">No voltage applied</p> <hr/> <p style="text-align: center;">X7R : ±15 X8R : ±15</p> <hr/>	<p>Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step.</p> <p><math>\Delta C</math> be calculated ref. STEP3 reading</p> <table border="1" data-bbox="992 422 1398 663"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference temp. ± 2</td> </tr> <tr> <td>2</td> <td>Min. operating temp. ± 2</td> </tr> <tr> <td>3</td> <td>Reference temp. ± 2</td> </tr> <tr> <td>4</td> <td>Max. operating temp. ± 2</td> </tr> </tbody> </table>	Step	Temperature(°C)	1	Reference temp. ± 2	2	Min. operating temp. ± 2	3	Reference temp. ± 2	4	Max. operating temp. ± 2
Step	Temperature(°C)												
1	Reference temp. ± 2												
2	Min. operating temp. ± 2												
3	Reference temp. ± 2												
4	Max. operating temp. ± 2												
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	<p>Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) and apply a pushing force of 5N with 10±1s.</p> 										
8	Bending	No mechanical damage.	<p>Reflow solder the capacitor on P.C. board (shown in Appendix 2) and bends 1mm.</p>  <p style="text-align: right;">(Unit: mm)</p>										

(8. Performance, continued)

No.	Item	Performance	Test or inspection method						
9	Solderability	<p>New solder to cover over 75% of termination.                      25% may have pin holes or rough spots but not concentrated in one spot.                      Ceramic surface of "A sections" shall not be exposed due to melting or shifting of termination material.</p> 	<p>Completely soak both terminations in solder at 235±5°C for 2±0.5s.</p> <p>Solder : H63A (JIS Z 3282)</p> <p>Flux : Isopropyl alcohol (JIS K 8839)                      Rosin(JIS K 5902) 25% solid solution.</p>						
10	Resistance to solder heat	External appearance	No cracks are allowed and terminations shall be covered at least 60% with new solder.						
		Capacitance	<table border="1"> <thead> <tr> <th colspan="2">Characteristics</th> <th>Change from the value before test</th> </tr> </thead> <tbody> <tr> <td>Class 2</td> <td>X7R X8R</td> <td>± 7.5 % ± 7.5 %</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class 2	X7R X8R	± 7.5 % ± 7.5 %
		Characteristics		Change from the value before test					
		Class 2	X7R X8R	± 7.5 % ± 7.5 %					
		D.F. (Class 2)	Meet the initial spec.						
Insulation Resistance	Meet the initial spec.								
Voltage proof	No insulation breakdown or other damage.								
			<p>Completely soak both terminations in solder at 260±5°C for 5±1s.</p> <p>Preheating condition                      Temp. : 150±10°C                      Time : 1 to 2min.</p> <p>Flux : Isopropyl alcohol (JIS K 8839)                      Rosin (JIS K 5902) 25% solid solution.</p> <p>Solder : H63A (JIS Z 3282)</p> <p>Leave the capacitor in ambient conditions for 24±2h before measurement.</p>						

(8. Performance, continued)

No.	Item		Performance	Test or inspection method															
11	Vibration	External appearance	No mechanical damage.	Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.  Vibrate the capacitor with amplitude of 1.5mm P-P changing the frequencies from 10Hz to 55Hz and back to 10Hz in about 1min. Repeat this for 2h each in 3 perpendicular directions.															
		Capacitance	Characteristics		Change from the value before test														
			Class 2		X7R X8R	± 7.5 % ± 7.5 %													
D.F. (Class 2)	Meet the initial spec.																		
12	Temperature cycle	External appearance	No mechanical damage.	Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.  Expose the capacitor in the conditions step1 through step 4 and repeat 5 times consecutively.  Leave the capacitor in ambient conditions for 24±2h before measurement.															
		Capacitance	Characteristics		Change from the value before test														
			Class 2		X7R X8R	± 7.5 % ± 7.5 %													
		D.F. (Class 2)	Meet the initial spec.																
		Insulation Resistance	Meet the initial spec.																
Voltage proof	No insulation breakdown or other damage.																		
				<table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> <th>Time (min.)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. operating temp. ±3</td> <td>30 ± 3</td> </tr> <tr> <td>2</td> <td>Reference Temp.</td> <td>2 - 5</td> </tr> <tr> <td>3</td> <td>Max. operating temp. ±2</td> <td>30 ± 2</td> </tr> <tr> <td>4</td> <td>Reference Temp.</td> <td>2 - 5</td> </tr> </tbody> </table>	Step	Temperature(°C)	Time (min.)	1	Min. operating temp. ±3	30 ± 3	2	Reference Temp.	2 - 5	3	Max. operating temp. ±2	30 ± 2	4	Reference Temp.	2 - 5
Step	Temperature(°C)	Time (min.)																	
1	Min. operating temp. ±3	30 ± 3																	
2	Reference Temp.	2 - 5																	
3	Max. operating temp. ±2	30 ± 2																	
4	Reference Temp.	2 - 5																	

## (8. Performance, continued)

No.	Item	Performance	Test or inspection method						
13	Moisture Resistance (Steady State)	External appearance	No mechanical damage.						
		Capacitance	<table border="1"> <thead> <tr> <th colspan="2">Characteristics</th> <th>Change from the value before test</th> </tr> </thead> <tbody> <tr> <td>Class 2</td> <td>X7R X8R</td> <td>± 12.5 % ± 12.5 %</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class 2	X7R X8R	± 12.5 % ± 12.5 %
			Characteristics		Change from the value before test				
		Class 2	X7R X8R	± 12.5 % ± 12.5 %					
D.F. (Class 2)	Characteristics X7R: 200% of initial spec. max. X8R: 200% of initial spec. max								
Insulation Resistance	1,000MΩ or 50MΩ·μF min. whichever smaller. (As for the capacitors of rated voltage 16V DC, 1,000 MΩ or 10MΩ·μF min.,)								
<p>Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Leave at temperature 40±2°C, 90 to 95%RH for 500 +24,0h.</p> <p>Leave the capacitor in ambient conditions for 24±2h before measurement.</p>									
14	Moisture Resistance	External appearance	No mechanical damage.						
		Capacitance	<table border="1"> <thead> <tr> <th colspan="2">Characteristics</th> <th>Change from the value before test</th> </tr> </thead> <tbody> <tr> <td>Class 2</td> <td>X7R X8R</td> <td>± 12.5 % ± 12.5 %</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class 2	X7R X8R	± 12.5 % ± 12.5 %
			Characteristics		Change from the value before test				
		Class 2	X7R X8R	± 12.5 % ± 12.5 %					
D.F. (Class 2)	Characteristics X7R: 200% of initial spec. max. X8R: 200% of initial spec. max								
Insulation Resistance	500MΩ or 25MΩ·μF min. whichever smaller. (As for the capacitors of rated voltage 16V DC, 500 MΩ or 5MΩ·μF min.,)								
<p>Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Apply the rated voltage at temperature 40±2°C and 90 to 95%RH for 500 +24,0h.</p> <p>Charge/discharge current shall not exceed 50mA.</p> <p>Leave the capacitor in ambient conditions for 24±2h before measurement.</p> <p>Voltage conditioning : Voltage treat the capacitor under testing temperature and voltage for 1 hour.</p> <p>Leave the capacitor in ambient conditions for 24±2h before measurement.</p> <p>Use this measurement for initial value.</p>									

(8. Performance, continued)

No.	Item	Performance	Test or inspection method						
15	Life	External appearance	No mechanical damage.						
		Capacitance	<table border="1" data-bbox="560 348 943 520"> <thead> <tr> <th colspan="2" data-bbox="560 348 740 415">Characteristics</th> <th data-bbox="740 348 943 415">Change from the value before test</th> </tr> </thead> <tbody> <tr> <td data-bbox="560 415 667 520">Class 2</td> <td data-bbox="667 415 740 520">X7R X8R</td> <td data-bbox="740 415 943 520">± 15 % ± 15 %</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class 2	X7R X8R	± 15 % ± 15 %
	Characteristics		Change from the value before test						
	Class 2	X7R X8R	± 15 % ± 15 %						
	D.F. (Class 2)	Characteristics X7R: 200% of initial spec. max. X8R: 200% of initial spec. max							
	Insulation Resistance	1,000MΩ or 50MΩ·μF min. whichever smaller (As for the capacitors of rated voltage 16V DC, 1,000 MΩ or 10MΩ μF min.)							

Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.

Below the voltage shall be applied at Maximum operating temperature ±2°C for 1,000 +48, 0h.

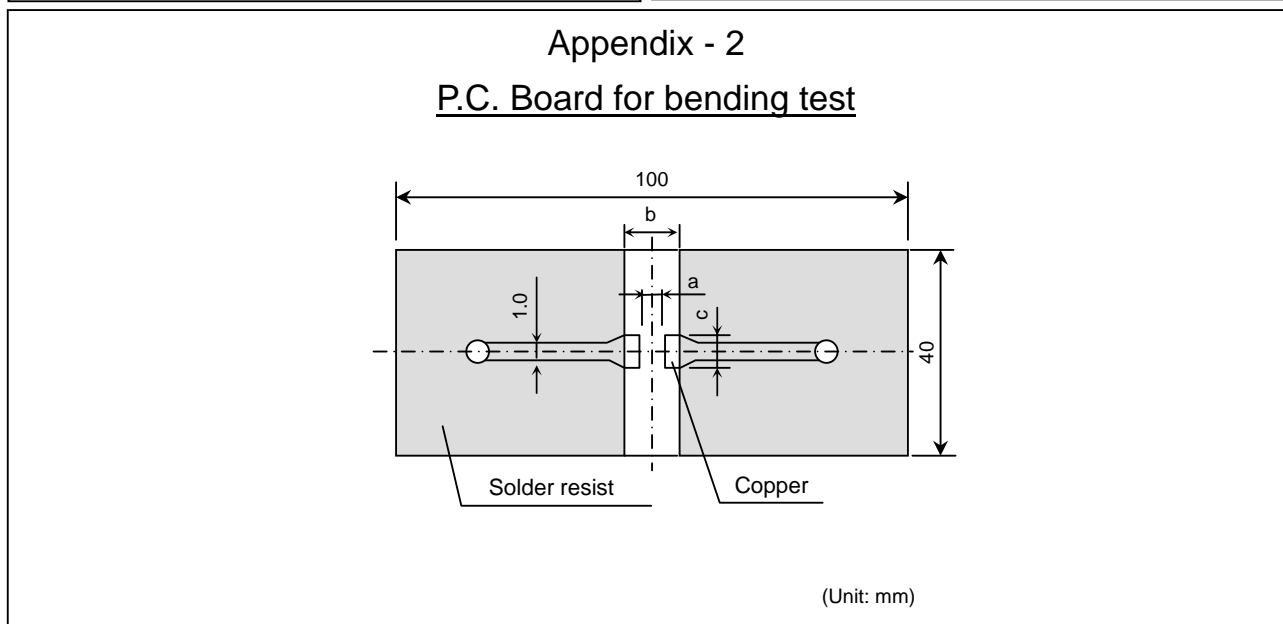
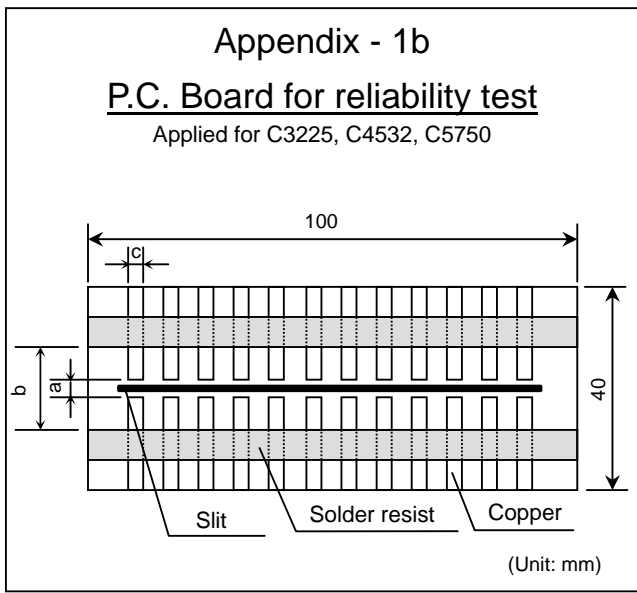
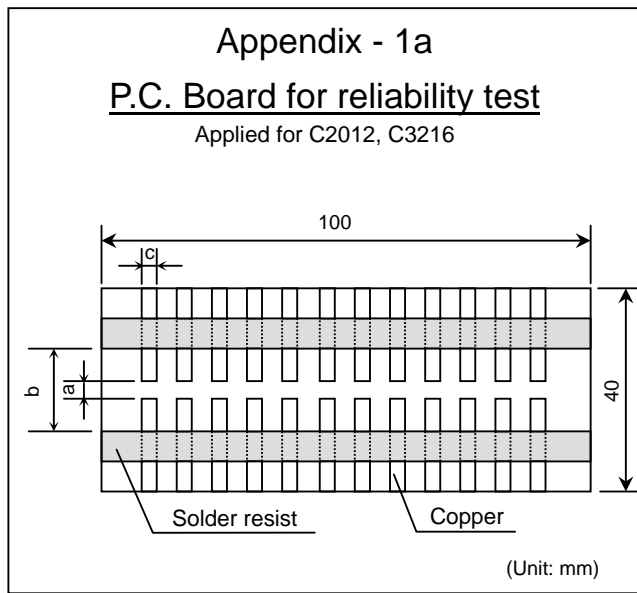
Applied voltage is 1xRV. Some items may be tested at higher voltage (1.2x, 1.5x or 2xRV).

Charge/discharge current shall not exceed 50mA.

Leave the capacitor in ambient conditions for 24±2h before measurement.

Voltage conditioning:  
Voltage treat the capacitor under testing temperature and voltage for 1 hour.  
Leave the capacitor in ambient conditions for 24±2h before measurement.  
Use this measurement for initial value.

\*As for the initial measurement of capacitors (Class 2) on number 6, 10, 11, 12 and 13, leave capacitor at 150 -10, 0°C for 1 hour and measure the value after leaving capacitor for 24±2h in ambient condition.



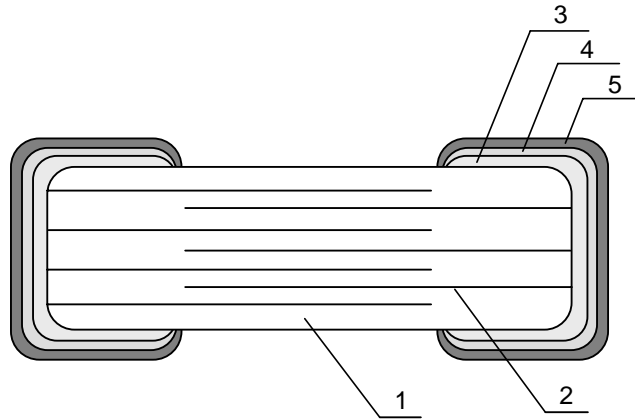
Material: Glass Epoxy (As per JIS C6484 GE4)

P.C. Board thickness: 1.6mm

- Copper (thickness 0.035mm)
- Solder resist

TDK (EIA style)	Dimensions (mm)		
	a	b	c
C2012 (CC0805)	1.2	4.0	1.65
C3216 (CC1206)	2.2	5.0	2.0
C3225 (CC1210)	2.2	5.0	2.9
C4532 (CC1812)	3.5	7.0	3.7
C5750 (CC2220)	4.5	8.0	5.6

## 9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL
1	Dielectric	BaTiO <sub>3</sub>
2	Electrode	Nickel (Ni)
3	Termination	Copper (Cu)
4		Nickel (Ni)
5		Tin (Sn)

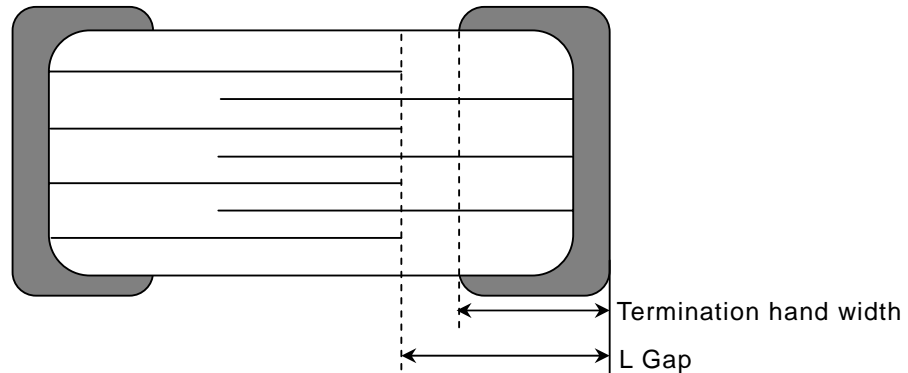
## 10. RECOMMENDATION

As for C3225, C4532 and C5750 types, it is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing flux. Please make sure to completely remove all cleaning solvents.

## 11. SOLDERING CONDITION

As for C3225, C4532 and C5750 types reflow soldering only.

## 12. DESIGN CONCEPT OF THE OPEN-MODE



< L gap >

Distance between the end of the opposite electrode and the termination.

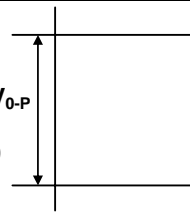
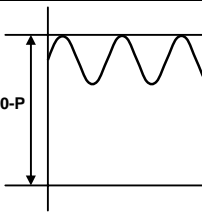
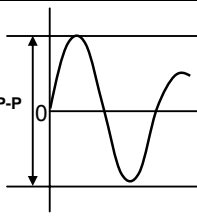
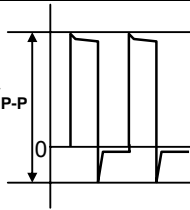
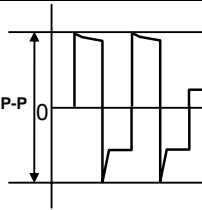
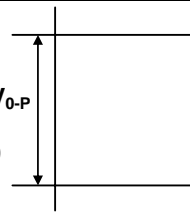
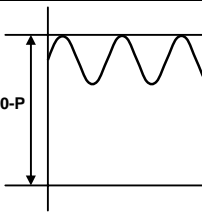
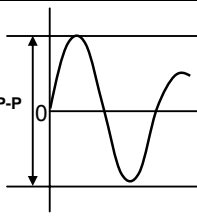
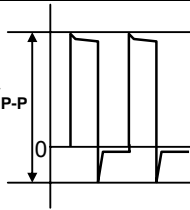
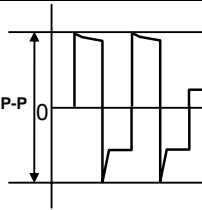
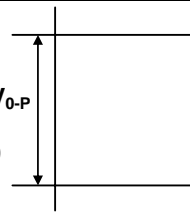
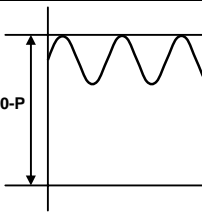
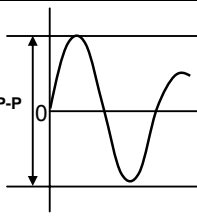
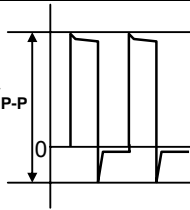
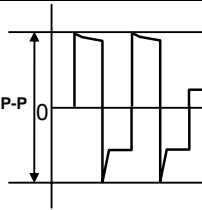
L Gap > Terminal band width

When a chip capacitor is cracked by mechanical stress such as board bending, open-mode construction helps to reduce the risk of short circuits.

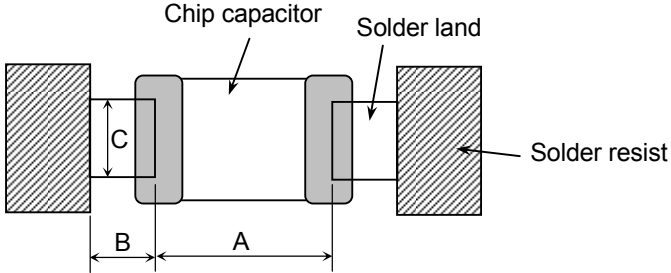
Open-mode is a product design concept, and it is predicted that open-mode construction will result in a decreased number of shorts in our capacitors.

However because we can not predict the specific types of mechanical stress the capacitors will be subjected to, we can not guarantee absolute success.

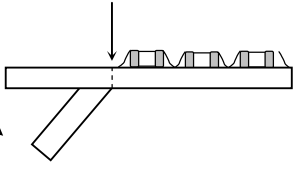
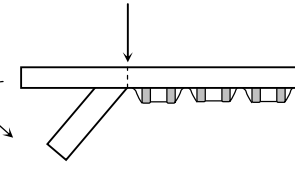
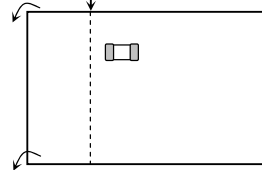
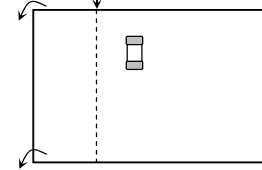
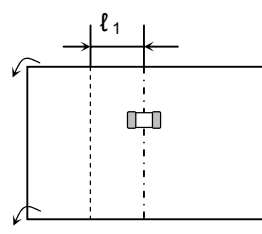
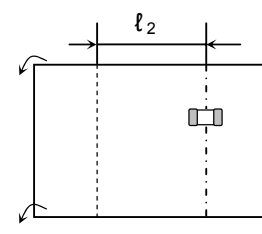
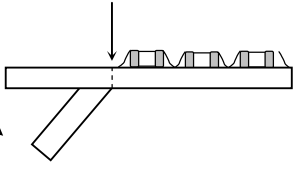
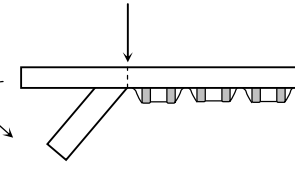
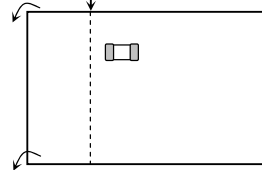
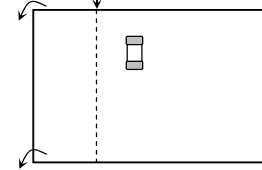
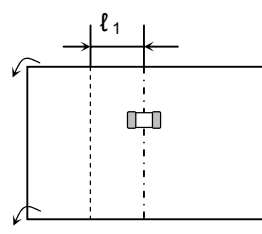
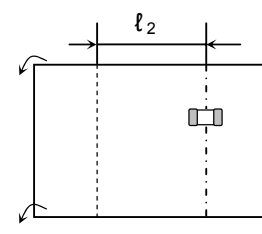
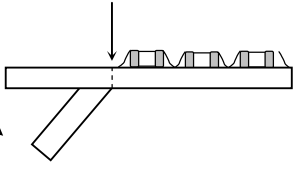
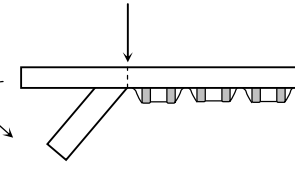
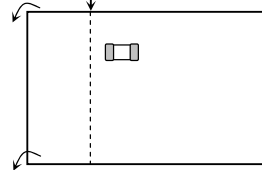
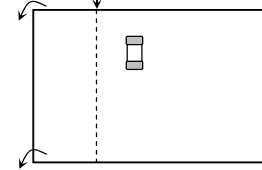
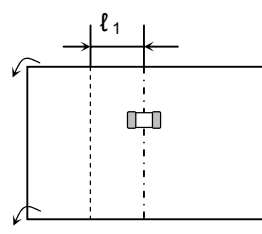
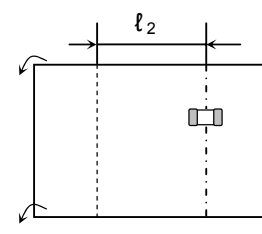
### 13. Caution

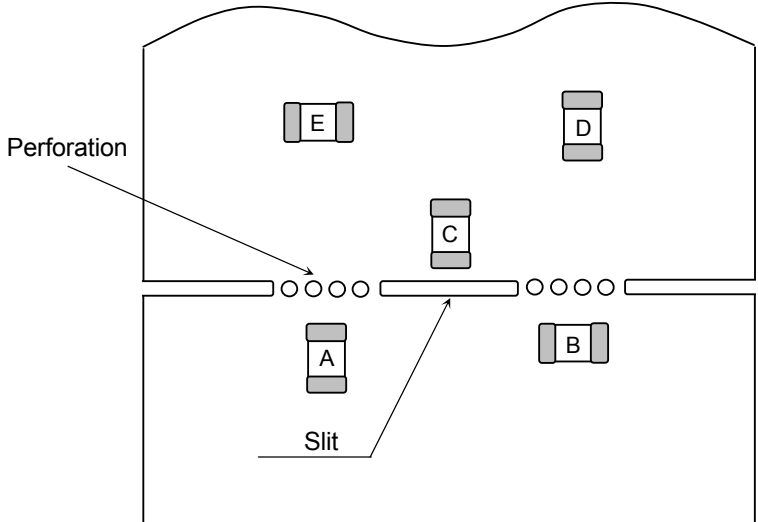
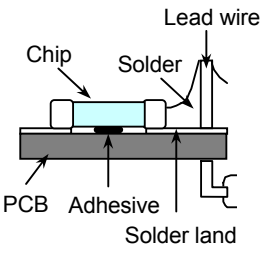
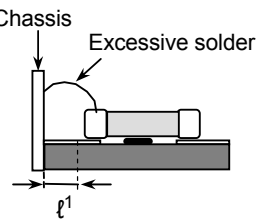
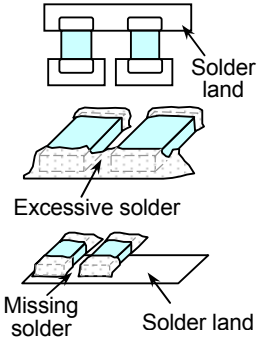
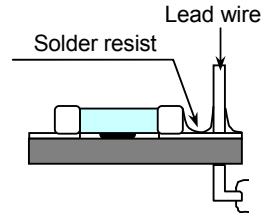
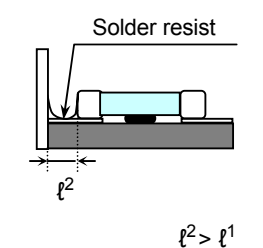
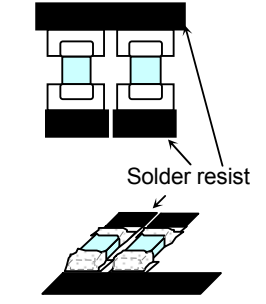
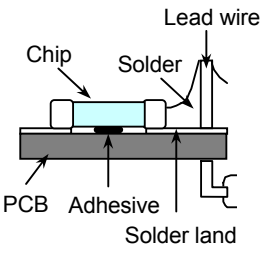
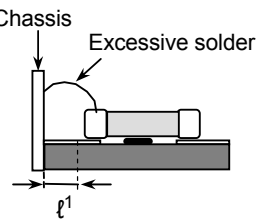
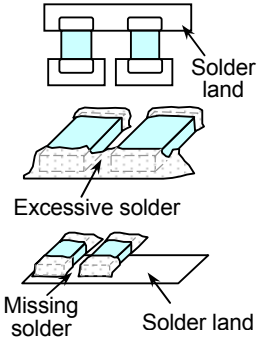
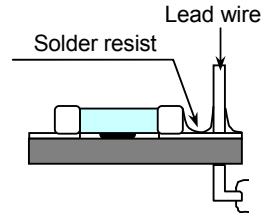
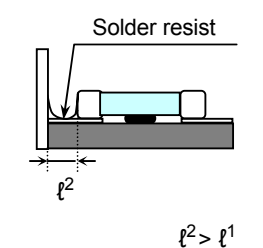
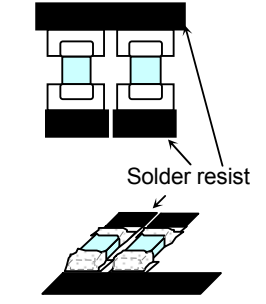
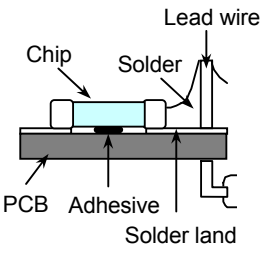
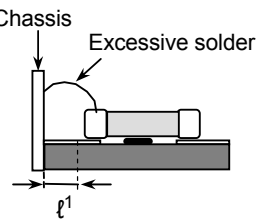
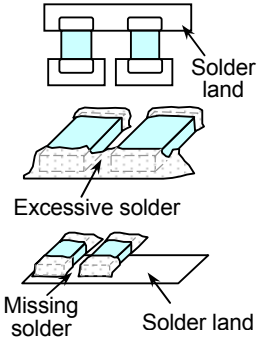
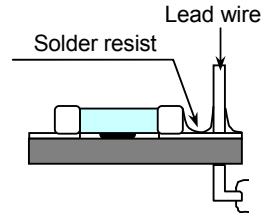
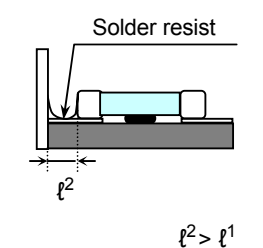
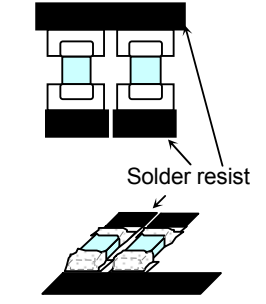
No.	Process	Condition														
1	Operating Condition (Storage, Transportation)	<p>1.1 Storage</p> <ol style="list-style-type: none"> <li>The capacitor must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The product should be used within 6 months upon receipt.</li> <li>The capacitor must be operated and stored in an environment free of condensation and corrosive gases such as hydrogen sulphide, hydrogen sulphate, chlorine, ammonia and sulfur.</li> <li>Avoid storing in sun light and falling of dew.</li> <li>Do not use capacitor under high humidity and high/low atmospheric pressure which may compromise product reliability.</li> <li>Capacitor should be tested for solderability when stored for long periods of time.</li> </ol> <p>1.2 Handling in transportation</p> <p>In case of the transportation, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 "Handling in transportation")</p>														
2	Circuit design	<p>2.1 Operating temperature</p> <p>Operating temperature should be followed strictly within this specification .</p> <ol style="list-style-type: none"> <li>Do not use capacitors above the maximum allowable operating temperature.</li> <li>Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product it's mounted on. Please design the circuit so that the maximum temperature of the capacitors (including the self heating) will be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be</li> <li>below 20°C)</li> </ol> <p>The electrical characteristics of the capacitor will vary depending on the temperature. The capacitor should be selected and designed after taking temperature into consideration.</p> <p>2.2 Operating voltage</p> <ol style="list-style-type: none"> <li>Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, <math>V_{0-P}</math> must be below the rated voltage. (Reference figures 1 and 2 below) AC or pulse with overshooting, <math>V_{P-P}</math> must be below the rated voltage. (Reference figures 3, 4, and 5 below) When the voltage is started/stopped to apply to the circuit an irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitor within its rated voltage during these Irregular voltage periods.</li> </ol> <table border="1" data-bbox="505 1367 1414 1623"> <thead> <tr> <th data-bbox="505 1367 683 1409">Voltage</th> <th data-bbox="683 1367 927 1409">(1) DC voltage</th> <th data-bbox="927 1367 1170 1409">(2) DC+AC voltage</th> <th data-bbox="1170 1367 1414 1409">(3) AC voltage</th> </tr> </thead> <tbody> <tr> <td data-bbox="505 1409 683 1623">Positional Measurement (Rated voltage)</td> <td data-bbox="683 1409 927 1623">  </td> <td data-bbox="927 1409 1170 1623">  </td> <td data-bbox="1170 1409 1414 1623">  </td> </tr> </tbody> </table> <table border="1" data-bbox="505 1650 1170 1900"> <thead> <tr> <th data-bbox="505 1650 683 1692">Voltage</th> <th data-bbox="683 1650 927 1692">(4) Pulse voltage (A)</th> <th data-bbox="927 1650 1170 1692">(5) Pulse voltage (B)</th> </tr> </thead> <tbody> <tr> <td data-bbox="505 1692 683 1900">Positional Measurement (Rated voltage)</td> <td data-bbox="683 1692 927 1900">  </td> <td data-bbox="927 1692 1170 1900">  </td> </tr> </tbody> </table>	Voltage	(1) DC voltage	(2) DC+AC voltage	(3) AC voltage	Positional Measurement (Rated voltage)				Voltage	(4) Pulse voltage (A)	(5) Pulse voltage (B)	Positional Measurement (Rated voltage)		
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(13. Caution, continued)

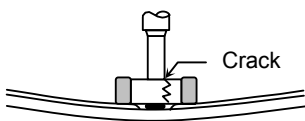
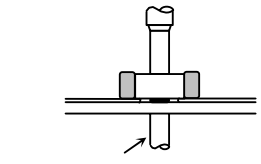
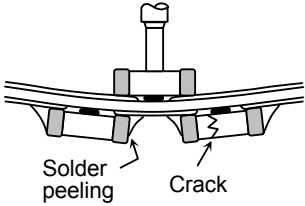
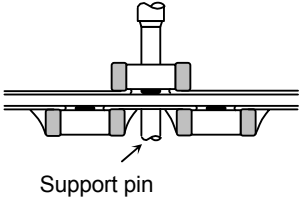
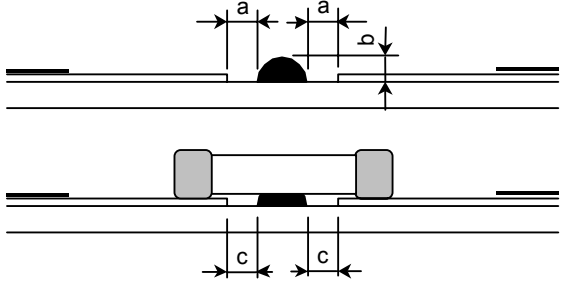
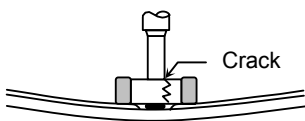
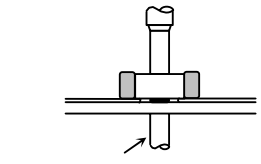
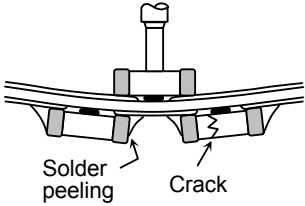
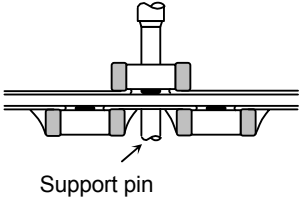
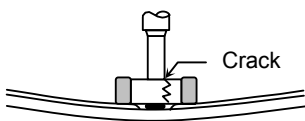
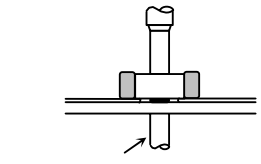
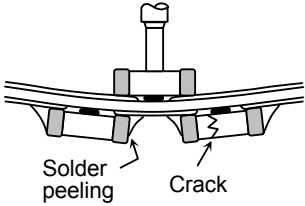
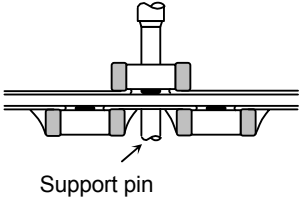
No.	Process	Condition																																								
2	Circuit design (continued)	<p>2.2 Operating Voltage (continued)</p> <p>2. Even below the rated voltage, if repetitive high AC frequency or pulsed voltage is applied, the reliability of the capacitors may be reduced.</p> <p>3. The effective capacitance will vary depending on applied DC and AC voltages. The capacitor should be selected after considering the voltage affects.</p> <p>2.3 Frequency</p> <p>When Class 2 capacitors are used in AC and/or pulsed voltages, the capacitor may self vibrate and generate audible sound (piezoelectric affect).</p>																																								
3	Designing P.C. Board	<p>The amount of solder at the terminations has a direct effect on the reliability of the capacitor.</p> <ol style="list-style-type: none"> <li>The greater the amount of solder, the higher the stress on the chip capacitor, and the more likely that it will break. When designing a P.C. board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.</li> <li>Avoid using common solder land for multiple terminations and provide individual solder land for each termination instead.</li> <li>Size and recommended land dimensions provided below:</li> </ol> <div style="text-align: center;">  </div> <p style="text-align: center;">Flow soldering (mm)</p> <table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>Type</th> <th>C2012 [CC0805]</th> <th>C3216 [CC1206]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>1.0 - 1.3</td> <td>2.1 - 2.5</td> </tr> <tr> <td>B</td> <td>1.0 - 1.2</td> <td>1.1 - 1.3</td> </tr> <tr> <td>C</td> <td>0.8 - 1.1</td> <td>1.0 - 1.3</td> </tr> </tbody> </table> <p style="text-align: center;">Reflow soldering (mm)</p> <table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>Type</th> <th>C2012 [CC0805]</th> <th>C3216 [CC1206]</th> <th>C3225 [CC1210]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>0.9 - 1.2</td> <td>2.0 - 2.4</td> <td>2.0 - 2.4</td> </tr> <tr> <td>B</td> <td>0.7 - 0.9</td> <td>1.0 - 1.2</td> <td>1.0 - 1.2</td> </tr> <tr> <td>C</td> <td>0.9 - 1.2</td> <td>1.1 - 1.6</td> <td>1.9 - 2.5</td> </tr> </tbody> </table> <table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>Type</th> <th>C4532 [CC1812]</th> <th>C5750 [CC2220]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>3.1 - 3.7</td> <td>4.1 - 4.8</td> </tr> <tr> <td>B</td> <td>1.2 - 1.4</td> <td>1.2 - 1.4</td> </tr> <tr> <td>C</td> <td>2.4 - 3.2</td> <td>4.0 - 5.0</td> </tr> </tbody> </table>	Type	C2012 [CC0805]	C3216 [CC1206]	A	1.0 - 1.3	2.1 - 2.5	B	1.0 - 1.2	1.1 - 1.3	C	0.8 - 1.1	1.0 - 1.3	Type	C2012 [CC0805]	C3216 [CC1206]	C3225 [CC1210]	A	0.9 - 1.2	2.0 - 2.4	2.0 - 2.4	B	0.7 - 0.9	1.0 - 1.2	1.0 - 1.2	C	0.9 - 1.2	1.1 - 1.6	1.9 - 2.5	Type	C4532 [CC1812]	C5750 [CC2220]	A	3.1 - 3.7	4.1 - 4.8	B	1.2 - 1.4	1.2 - 1.4	C	2.4 - 3.2	4.0 - 5.0
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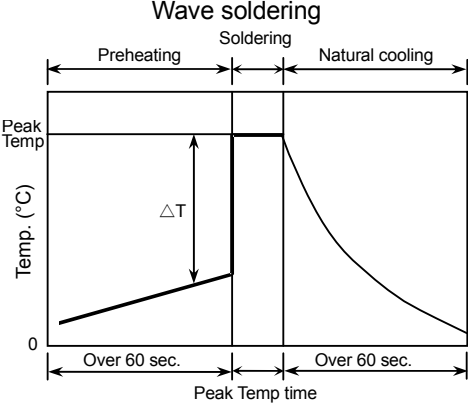
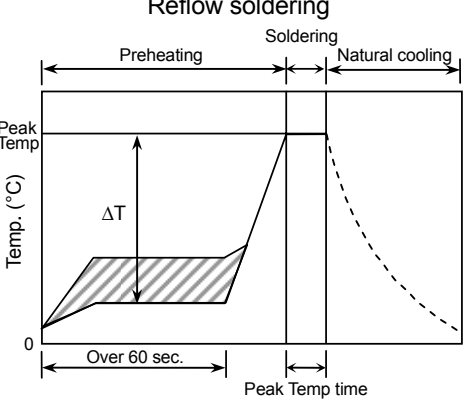
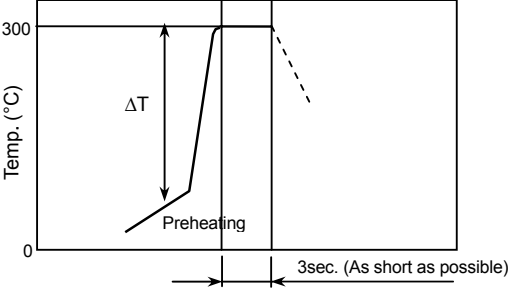
(13. Caution, continued)

No.	Process	Condition												
3	Designing P.C. Board (continued)	<p>4. Recommended chip capacitor layout is provided below:</p> <table border="1"> <thead> <tr> <th data-bbox="506 235 683 310"></th> <th data-bbox="683 235 1040 310">Disadvantage against bending stress</th> <th data-bbox="1040 235 1398 310">Advantage against bending stress</th> </tr> </thead> <tbody> <tr> <td data-bbox="506 310 683 701">Mounting face</td> <td data-bbox="683 310 1040 701"> <p>Perforation or slit</p>  <p>Break P.C. board with mounted side up.</p> </td> <td data-bbox="1040 310 1398 701"> <p>Perforation or slit</p>  <p>Break P.C. board with mounted side down.</p> </td> </tr> <tr> <td data-bbox="506 701 683 1121">Chip arrangement (Direction)</td> <td data-bbox="683 701 1040 1121"> <p>Mount perpendicularly to perforation or slit</p> <p>Perforation or slit</p>  </td> <td data-bbox="1040 701 1398 1121"> <p>Mount in parallel with perforation or slit</p> <p>Perforation or slit</p>  </td> </tr> <tr> <td data-bbox="506 1121 683 1570">Distance from slit</td> <td data-bbox="683 1121 1040 1570"> <p>Closer to slit is higher stress</p>  <p><math>(l_1 &lt; l_2)</math></p> </td> <td data-bbox="1040 1121 1398 1570"> <p>Away from slit is less stress</p>  <p><math>(l_1 &lt; l_2)</math></p> </td> </tr> </tbody> </table>		Disadvantage against bending stress	Advantage against bending stress	Mounting face	<p>Perforation or slit</p>  <p>Break P.C. board with mounted side up.</p>	<p>Perforation or slit</p>  <p>Break P.C. board with mounted side down.</p>	Chip arrangement (Direction)	<p>Mount perpendicularly to perforation or slit</p> <p>Perforation or slit</p> 	<p>Mount in parallel with perforation or slit</p> <p>Perforation or slit</p> 	Distance from slit	<p>Closer to slit is higher stress</p>  <p><math>(l_1 &lt; l_2)</math></p>	<p>Away from slit is less stress</p>  <p><math>(l_1 &lt; l_2)</math></p>
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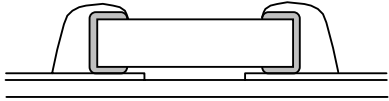
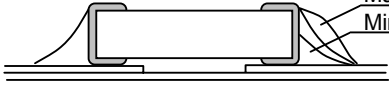
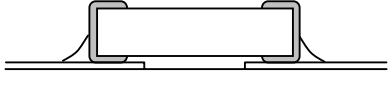
No.	Process	Condition												
3	Designing P.C. Board (continued)	<p>5. Mechanical stress varies according to location of chip capacitor on the P.C. board.</p>  <p>The relative stress applied to these capacitors during depaneling is in the following order:  <math>A &gt; B = C &gt; D &gt; E</math></p> <p>6. Layout recommendation</p> <table border="1" data-bbox="418 947 1442 1801"> <thead> <tr> <th data-bbox="423 953 570 1052">Example</th> <th data-bbox="574 953 857 1052">Use of common solder land</th> <th data-bbox="862 953 1144 1052">Soldering with chassis</th> <th data-bbox="1149 953 1437 1052">Use of common solder land with other SMD</th> </tr> </thead> <tbody> <tr> <td data-bbox="423 1058 570 1409">Need to avoid</td> <td data-bbox="574 1058 857 1409">  </td> <td data-bbox="862 1058 1144 1409">  </td> <td data-bbox="1149 1058 1437 1409">  </td> </tr> <tr> <td data-bbox="423 1415 570 1795">Recommendation</td> <td data-bbox="574 1415 857 1795">  </td> <td data-bbox="862 1415 1144 1795">  </td> <td data-bbox="1149 1415 1437 1795">  </td> </tr> </tbody> </table>	Example	Use of common solder land	Soldering with chassis	Use of common solder land with other SMD	Need to avoid				Recommendation			
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Recommendation														

(13. Caution, continued)

No.	Process	Condition															
4	Mounting	<p>4.1 Stress from mounting head                      If the mounting head is adjusted too low, it may induce excessive stress on the chip capacitor and result in cracking. Please take following precautions:</p> <ol style="list-style-type: none"> <li>1. Adjust the bottom dead center of the mounting head to reach the P.C. board surface but not contact it.</li> <li>2. Adjust the mounting head pressure to be 1 to 3N of static weight.</li> <li>3. To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C. board.</li> </ol> <p>See following examples.</p> <table border="1" data-bbox="516 558 1403 1087"> <thead> <tr> <th></th> <th data-bbox="688 558 1057 611">Not recommended</th> <th data-bbox="1057 558 1403 611">Recommended</th> </tr> </thead> <tbody> <tr> <td data-bbox="516 611 688 842">Single sided mounting</td> <td data-bbox="688 611 1057 842">  </td> <td data-bbox="1057 611 1403 842">  </td> </tr> <tr> <td data-bbox="516 842 688 1087">Double-sides mounting</td> <td data-bbox="688 842 1057 1087">  </td> <td data-bbox="1057 842 1403 1087">  </td> </tr> </tbody> </table> <p>When the centering jaw is worn, mechanical impact on the capacitor may occur and damage the product. Please control the closing dimension of the centering jaw and provide sufficient preventive maintenance and/or replacement if necessary.</p> <p>4.2 Amount of adhesive</p>  <p>Example : C2012 (CC0805), C3216 (CC1206)</p> <table border="1" data-bbox="683 1667 1198 1822"> <tbody> <tr> <td data-bbox="683 1667 821 1724">a</td> <td data-bbox="821 1667 1198 1724">0.2mm min.</td> </tr> <tr> <td data-bbox="683 1724 821 1780">b</td> <td data-bbox="821 1724 1198 1780">70 - 100μm</td> </tr> <tr> <td data-bbox="683 1780 821 1822">c</td> <td data-bbox="821 1780 1198 1822">Do not touch the solder land</td> </tr> </tbody> </table>		Not recommended	Recommended	Single sided mounting			Double-sides mounting			a	0.2mm min.	b	70 - 100μm	c	Do not touch the solder land
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No.	Process	Condition																			
5	Soldering	<p>5.1 Flux selection</p> <p>Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitor. To avoid such degradation, the following is recommended.</p> <ol style="list-style-type: none"> <li>1. Use a mildly activated rosin flux (less than 0.1wt% chlorine).</li> <li>2. Excessive flux must be avoided. Please provide proper amount of flux.</li> <li>3. When water-soluble flux is used, sufficient washing is necessary.</li> </ol> <p>5.2 Recommended soldering profile by various methods</p> <div style="display: flex; justify-content: space-around;"> <div style="text-align: center;"> <p>Wave soldering</p>  </div> <div style="text-align: center;"> <p>Reflow soldering</p>  </div> </div> <div style="text-align: center; margin-top: 20px;"> <p>Manual soldering (Solder iron)</p>  </div> <div style="margin-top: 20px;"> <p><b>APPLICATION</b></p> <p>As for C2012 (CC0805) and C3216 (CC1206), applied to wave soldering and reflow soldering. As for C3225 (CC1210), C4532 (CC1812), C5750 (CC2220), applied only to reflow soldering.</p> </div> <p>5.3 Recommended soldering peak temp and duration</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th rowspan="2" style="text-align: center;">Temp./Duration</th> <th colspan="2" style="text-align: center;">Wave soldering</th> <th colspan="2" style="text-align: center;">Reflow soldering</th> </tr> <tr> <th style="text-align: center;">Peak temp(°C)</th> <th style="text-align: center;">Duration(sec.)</th> <th style="text-align: center;">Peak temp(°C)</th> <th style="text-align: center;">Duration(sec.)</th> </tr> </thead> <tbody> <tr> <td style="text-align: center;">Sn-Pb Solder</td> <td style="text-align: center;">250 max.</td> <td style="text-align: center;">3 max.</td> <td style="text-align: center;">230 max.</td> <td style="text-align: center;">20 max.</td> </tr> <tr> <td style="text-align: center;">Lead Free Solder</td> <td style="text-align: center;">260 max.</td> <td style="text-align: center;">5 max.</td> <td style="text-align: center;">260 max.</td> <td style="text-align: center;">10 max.</td> </tr> </tbody> </table> <p>Recommended solder compositions Sn-37Pb (Sn-Pb solder) Sn-3.0Ag-0.5Cu (Lead Free Solder)</p>	Temp./Duration	Wave soldering		Reflow soldering		Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)	Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.	Lead Free Solder	260 max.	5 max.	260 max.	10 max.
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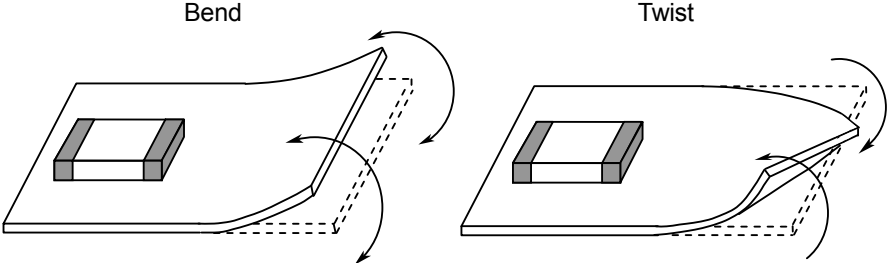
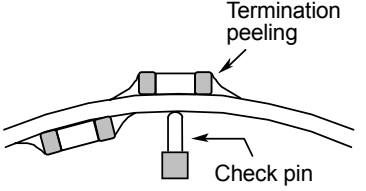
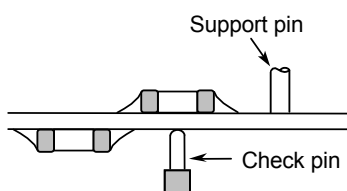
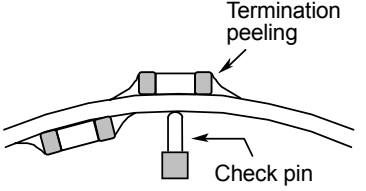
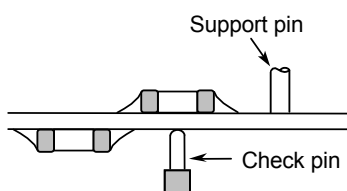
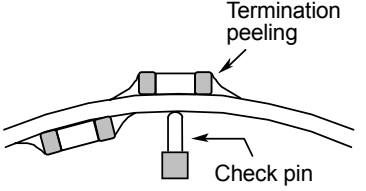
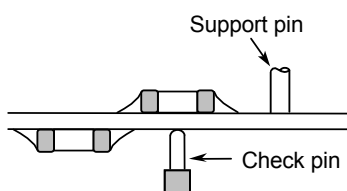
(13. Caution, continued)

No.	Process	Condition																								
5	Soldering (continued)	<p>5.4 Avoiding thermal shock</p> <p>1. Preheating condition</p> <table border="1" data-bbox="592 247 1406 583"> <thead> <tr> <th>Soldering</th> <th>Type</th> <th>Temp. (°C)</th> </tr> </thead> <tbody> <tr> <td>Wave soldering</td> <td>C2012(CC0805), C3216(CC1206)</td> <td><math>\Delta T \leq 150</math></td> </tr> <tr> <td rowspan="2">Reflow soldering</td> <td>C2012(CC0805), C3216(CC1206)</td> <td><math>\Delta T \leq 150</math></td> </tr> <tr> <td>C3225(CC1210), C4532(CC1812), C5750(CC2220)</td> <td><math>\Delta T \leq 130</math></td> </tr> <tr> <td rowspan="2">Manual soldering</td> <td>C2012(CC0805), C3216(CC1206)</td> <td><math>\Delta T \leq 150</math></td> </tr> <tr> <td>C3225(CC1210), C4532(CC1812), C5750(CC2220)</td> <td><math>\Delta T \leq 130</math></td> </tr> </tbody> </table> <p>2. Cooling condition Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (<math>\Delta T</math>) must be less than 100°C.</p> <p>5.5 Amount of solder Excessive solder will induce higher tensile force on the chip capacitor during temperature changes and may result in chip cracking. In sufficient solder may detach the capacitor from the P.C. board.</p> <div style="display: flex; justify-content: space-between; align-items: flex-start;"> <div style="width: 30%;"> <p>Excessive solder</p>  </div> <div style="width: 60%;"> <p>Higher tensile force on the chip capacitor may cause cracking</p> </div> </div> <hr/> <div style="display: flex; justify-content: space-between; align-items: center;"> <div style="width: 30%;"> <p>Adequate solder</p>  </div> <div style="width: 60%;"> <p>Maximum amount Minimum amount</p> </div> </div> <hr/> <div style="display: flex; justify-content: space-between; align-items: flex-start;"> <div style="width: 30%;"> <p>Insufficient solder</p>  </div> <div style="width: 60%;"> <p>Small solder fillet may cause contact failure or not hold the chip capacitor the P.C. board.</p> </div> </div> <hr/> <p>5.6 Solder repair by solder iron</p> <p>1. Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C. board material and solder land size. Higher temperatures may provide the quicker the operation, however, heat shock may cause a crack in the chip capacitor. Please confirm the tip temperature. before soldering and keep the peak temperature and time in accordance with following recommended condition. (Please preheat the chip capacitors with the condition in 5.4 to avoid the thermal shock.)</p> <p>Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)</p> <table border="1" data-bbox="592 1705 1372 1810"> <thead> <tr> <th>Temp. (°C)</th> <th>Duration (sec.)</th> <th>Wattage (W)</th> <th>Shape (mm)</th> </tr> </thead> <tbody> <tr> <td>300 max.</td> <td>3 max.</td> <td>20 max.</td> <td>Ø 3.0 max.</td> </tr> </tbody> </table>	Soldering	Type	Temp. (°C)	Wave soldering	C2012(CC0805), C3216(CC1206)	$\Delta T \leq 150$	Reflow soldering	C2012(CC0805), C3216(CC1206)	$\Delta T \leq 150$	C3225(CC1210), C4532(CC1812), C5750(CC2220)	$\Delta T \leq 130$	Manual soldering	C2012(CC0805), C3216(CC1206)	$\Delta T \leq 150$	C3225(CC1210), C4532(CC1812), C5750(CC2220)	$\Delta T \leq 130$	Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)	300 max.	3 max.	20 max.	Ø 3.0 max.
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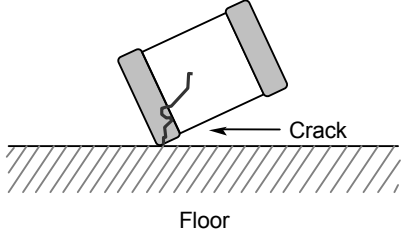
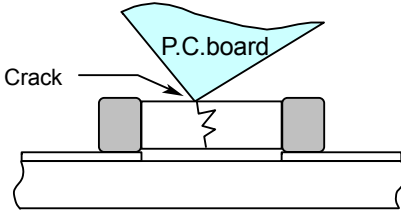
(13. Caution, continued)

No.	Process	Condition
5	Soldering (continued)	<p>2. Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.</p> <p>5.7 Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.</p> <p>5.8 Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially when the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 "Recommendations to prevent the tombstone phenomenon")</p>
6	Cleaning	<p>1. If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to the chip capacitor surface and deteriorate the insulation resistance.</p> <p>2. If cleaning condition is not suitable, it may deteriorate the chip capacitor's insulation resistance.</p> <p>2.1 Insufficient washing</p> <ol style="list-style-type: none"><li>1. Terminal electrodes may corroded by Halogen in the flux.</li><li>2. Halogen in the flux may adhere on the surface of capacitor, and lower the insulation resistance.</li><li>3. Water soluble flux has higher tendency to have above mentioned problems (1) and (2).</li></ol> <p>2.2 Excessive washing</p> <p>When ultrasonic cleaning is used, excessively high energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, the following is recommended.</p> <p style="text-align: center;">Power: 20 W/ ℓ max. Frequency: 40 kHz max. Washing time: 5 minutes max.</p> <p>2.3 If the cleaning fluid is contaminated, of Halogen concentration can increase, and bring the same result as insufficient cleaning.</p>

(13. Caution, continued)

No.	Process	Condition						
7	Coating and molding of the P.C. Board	<ol style="list-style-type: none"> <li>When the P.C. board is coated, please verify the impact on the capacitor.</li> <li>Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> <li>Please verify the curing temperature.</li> </ol>						
8	Handling after chip mounted	<ol style="list-style-type: none"> <li>Please pay attention not to bend or distort the P.C. board after soldering otherwise the chip capacitor may crack.                     <div style="text-align: center; margin: 10px 0;">  </div> </li> <li>When functional check of the P.C. board is performed, higher pin pressure tends to be used for fear of loose contact. But if the pressure is excessive and bends the P.C. board, it may crack the chip capacitor or peel the termination. Please adjust the pins accordingly to ensure P.C. board is not flexed.                     <table border="1" style="width: 100%; margin-top: 10px;"> <thead> <tr> <th data-bbox="526 1041 656 1096">Item</th> <th data-bbox="656 1041 1045 1096">Not recommended</th> <th data-bbox="1045 1041 1416 1096">Recommended</th> </tr> </thead> <tbody> <tr> <td data-bbox="526 1096 656 1377">Board bending</td> <td data-bbox="656 1096 1045 1377">  </td> <td data-bbox="1045 1096 1416 1377">  </td> </tr> </tbody> </table> </li> </ol>	Item	Not recommended	Recommended	Board bending		
Item	Not recommended	Recommended						
Board bending								

(13. Caution, continued)

No.	Process	Condition
9	Handling of loose chip capacitors	<p>1. The chip capacitor may crack if dropped, especially, large case sizes. Please handle with care and do not use if dropped.</p>  <p style="text-align: center;">Floor</p> <p>2. When stacking the P.C.board for storage or handling after soldering, the corner of the P. C. board may hit the chip capacitors of a neighboring board to cause a crack.</p> 
10	Capacitance aging	Class 2 capacitors have an aging characteristic, which is a decrease in capacitance over time due to crystalline changes that occur in ferroelectric ceramics. Careful consideration should be done in case of a time constant circuit.
11	Estimated life and estimated failure rate of capacitors	The estimated life (and the estimated failure rate) depend on the temperature and voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 "Calculation of the estimated lifetime and failure rate. The risk can be decreased by reducing the temperature and voltage but it will not be guaranteed.
12	Others	<p>The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.</p> <p>The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that TDK is not responsible for any damage or liability caused by use of this product in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet:</p> <p>Aerospace/Aviation equipment. Transportation equipment (cars, electric trains, ships, etc.) Medical equipment. Power-generation control equipment. Atomic energy-related equipment. Seabed equipment. Transportation control equipment.</p> <p>Public information-processing equipment. Military equipment. Electric heating apparatus, burning equipment. Disaster prevention/crime prevention equipment. Safety equipment. Other applications that are not considered general-purpose applications.</p> <p>When using this product in general-purpose applications, you are kindly requested to take into consideration securing protection circuit/equipment or providing backup circuits, etc., to ensure higher safety.</p>

## 14. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

\*Composition of Inspection No.

Example     M 0 A - 00 - 000  
                  (a) (b) (c)     (d)        (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

## 15. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs.

# 16. TAPE PACKAGING SPECIFICATION

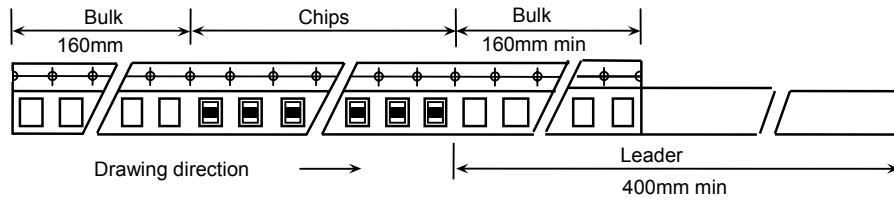
## 1. CONSTRUCTION AND DIMENSION OF TAPING

### 1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3.

Dimensions of plastic tape shall be according to Appendix 4, 5.

### 2. Bulk part and leader of taping

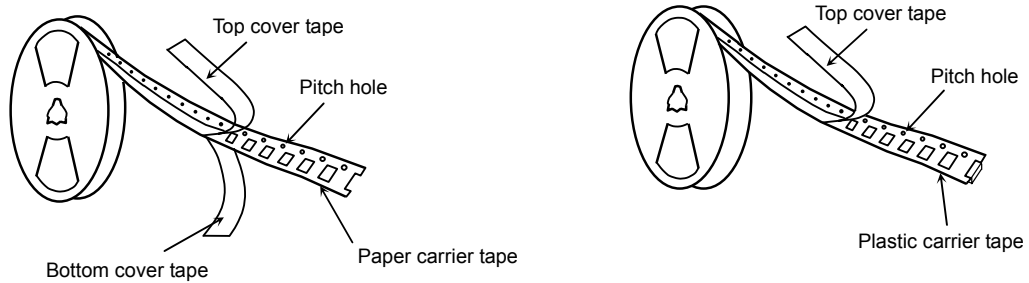


### 3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 6, 7.

Dimensions of Ø330 reel shall be according to Appendix 8, 9.

### 4. Structure of taping

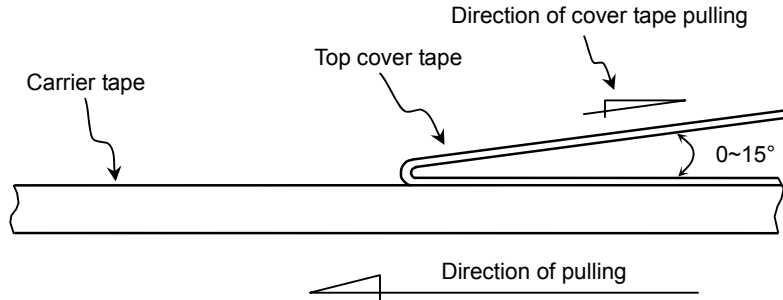


## 2. CHIP QUANTITY

Type	Thickness of chip	Taping Material	Chip quantity (pcs.)	
			φ178mm reel	φ330mm reel
C2012	0.85 mm	Paper *Plastic	4,000	10,000
	1.25 mm	Plastic	2,000	
C3216	1.15 mm	Plastic	2,000	10,000
	1.30 mm			8,000
	1.60 mm			
C3225	1.15 mm	Plastic	2,000	10,000
	1.60 mm			8,000
	2.00 mm		1,000	5,000
	2.30 mm			
	2.50 mm			
C4532	1.60 mm	Plastic	1,000	3,000
	2.00 mm			
	2.30 mm		500	
C5750	1.60 mm	Plastic	1,000	3,000
	2.00 mm		500	
	2.30 mm			2,000
	2.80 mm			

### 3. PERFORMANCE SPECIFICATIONS

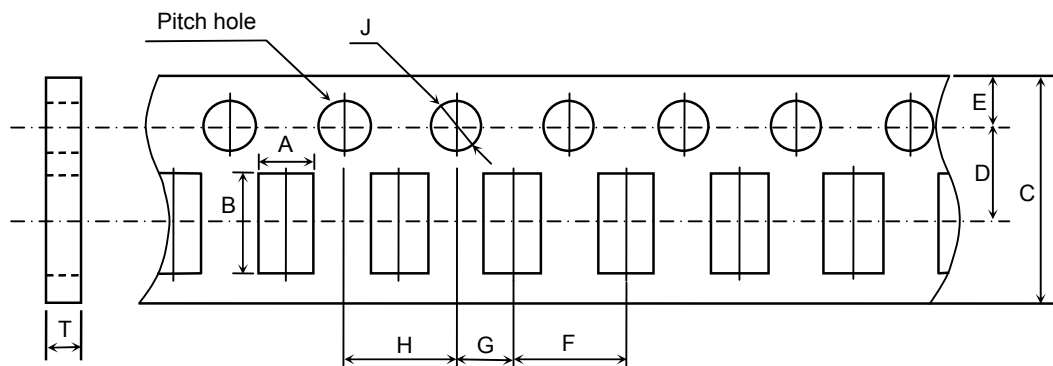
1. Peel back cover (top tape)  
0.05-0.7N. (See the following figure.)



2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
3. The missing of components shall be less than 0.1%
4. Components shall not stick to the cover tape.
5. The cover tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

## Appendix 3

### Paper Tape



(Unit: mm)

Symbol Type	A	B	C	D	E	F
C2012 (CC0805)	( 1.50 )	( 2.30 )	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10

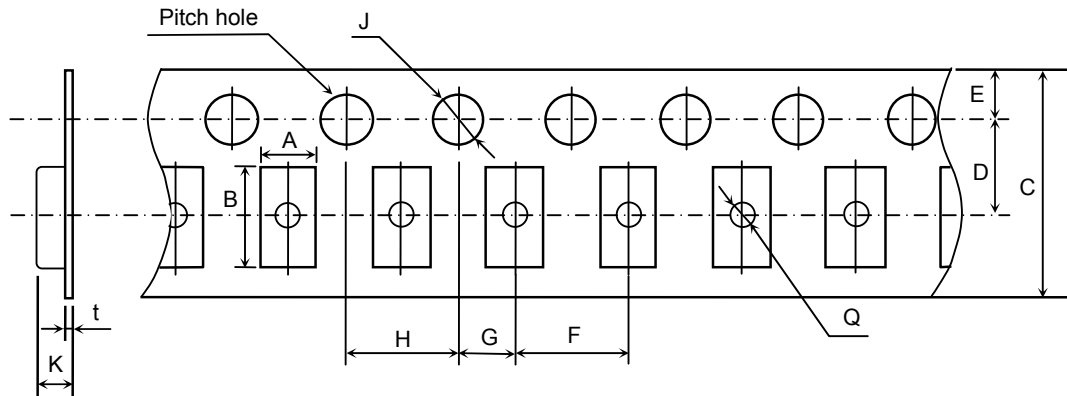
  

Symbol Type	G	H	J	T
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	∅ 1.5 $\begin{matrix} +0.10 \\ 0 \end{matrix}$	1.10 max.

\* The values in the parentheses ( ) are for reference.

# Appendix 4

## Plastic Tape



(Unit: mm)

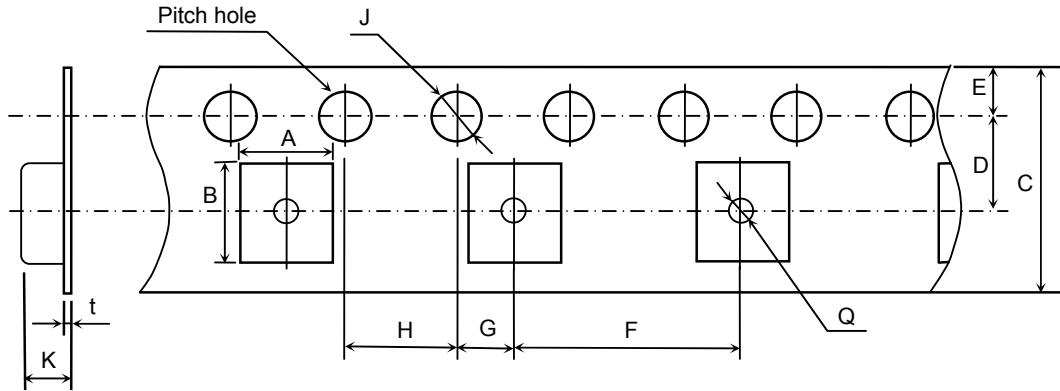
Symbol Type	A	B	C	D	E	F
C2012 (CC0805)	( 1.50 )	( 2.30 )	8.00 ± 0.30 [12.0 ± 0.30]	3.50 ± 0.05 [5.50 ± 0.05]	1.75 ± 0.10	4.00 ± 0.10
C3216 (CC1206)	( 1.90 )	( 3.50 )				
C3225 (CC1210)	( 2.90 )	( 3.60 )				
Symbol Type	G	H	J	K	t	Q
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	∅ 1.5 <sup>+0.10</sup> <sub>0</sub>	2.50 max.	0.30 max.	∅ 0.50 min.
C3216 (CC1206)				3.20 max.	0.60 max.	
C3225 (CC1210)						

\* The values in the parentheses ( ) are for reference.

\* As for 2.5mm thickness products, apply values in the brackets [ ].

# Appendix 5

## Plastic Tape



(Unit: mm)

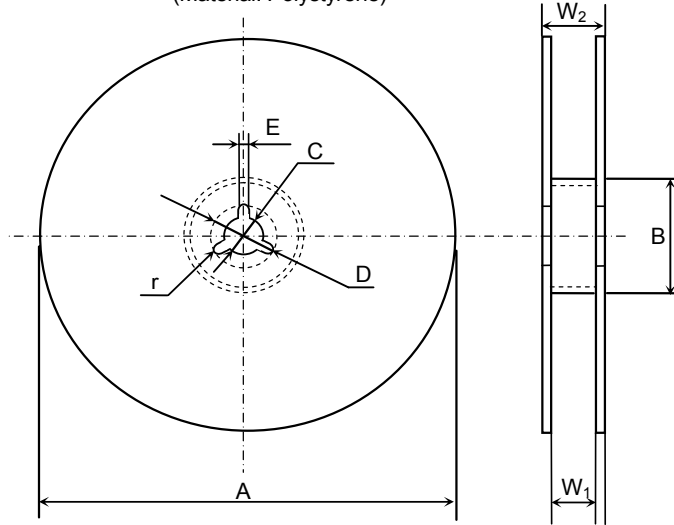
Symbol Type	A	B	C	D	E	F
C4532 (CC1812)	( 3.60 )	( 4.90 )	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 (CC2220)	( 5.40 )	( 6.10 )				
Symbol Type	G	H	J	K	t	Q
C4532 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	∅ 1.5 $\begin{matrix} +0.10 \\ 0 \end{matrix}$	6.50 max.	0.60 max.	∅ 1.50 min.
C5750 (CC2220)						

\* The values in the parentheses ( ) are for reference.

## Appendix 6

C2012, C3216, C3225 (As for C3225 type, any thickness of the item except 2.5mm)

(Material: Polystyrene)



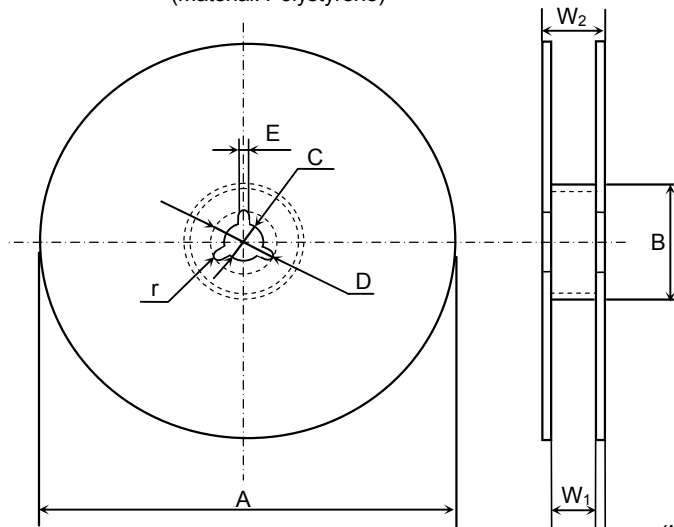
(Unit: mm)

Symbol	A	B	C	D	E	W <sub>1</sub>
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3
Symbol	W <sub>2</sub>	r				
Dimension	13.0 ± 1.4	1.0				

## Appendix 7

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products)

(Material: Polystyrene)



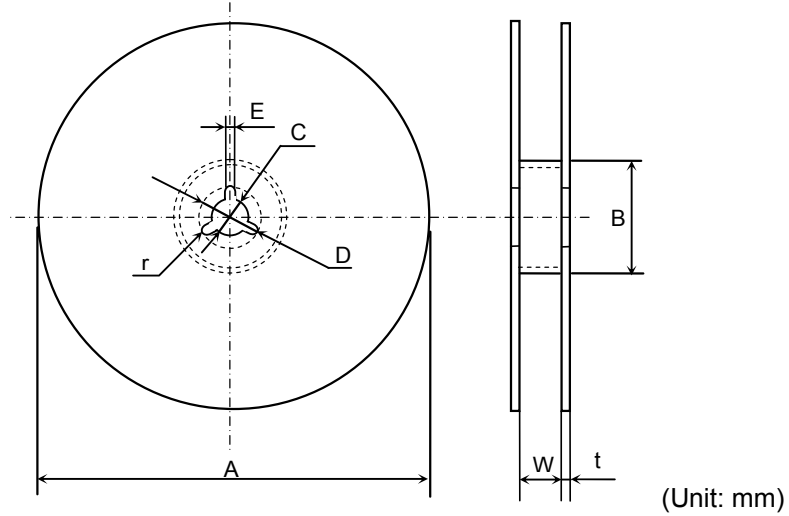
(Unit: mm)

Symbol	A	B	C	D	E	W <sub>1</sub>
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3
Symbol	W <sub>2</sub>	r				
Dimension	17.0 ± 1.4	1.0				

## Appendix 8

C2012, C3216, C3225 (As for C3225 type, any thickness of the item except 2.5mm)

(Material: Polystyrene)

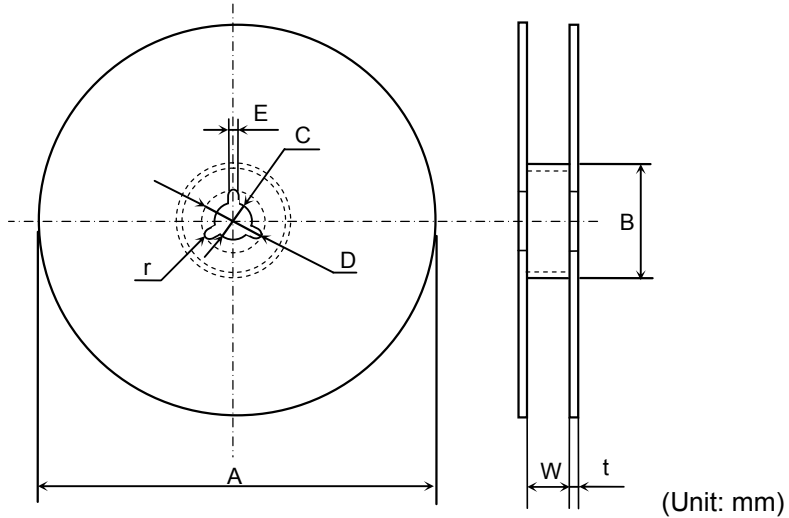


Symbol	A	B	C	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5
Symbol	t	r				
Dimension	2.0 ± 0.5	1.0				

## Appendix 9

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products)

(Material: Polystyrene)



Symbol	A	B	C	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5
Symbol	t	r				
Dimension	2.0 ± 0.5	1.0				

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